

Low Noise Silicon Bipolar RF Transistor

- General purpose low noise amplifier for low voltage, low current applications
- High ESD robustness, typical 1500 V (HBM)
- Low minimum noise figure 1.1 dB at 1.8 GHz
- High linearity: output compression point
 OP1dB = 13 dBm @ 3 V, 35 mA, 1.8 GHz
- Pb-free (RoHS compliant) and halogen-free package with visible leads
- Qualification report according to AEC-Q101 available

RoHS

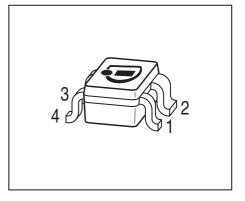
ESD (Electrostatic discharge) sensitive device, observe handling precaution!

Туре	Marking	Pin Configuration					Package	
BFP460	ABs	1 = E	2 = C	3 = E	4=B	-	-	SOT343

Maximum Ratings at $T_A = 25 \text{ °C}$, unless otherwise specified

Parameter	Symbol	Value	Unit	
Collector-emitter voltage	V _{CEO}		V	
<i>T</i> _A = 25 °C		4.5		
_T _A = -55 °C		4.2		
Collector-emitter voltage	V _{CES}	15		
Collector-base voltage	V _{CBO}	15		
Emitter-base voltage	V _{EBO}	1.5		
Collector current	I _C	70	mA	
Base current	I _B	7		
Total power dissipation ¹⁾	P _{tot}	230	mW	
<i>T</i> _S ≤ 92°C				
Junction temperature	TJ	150	°C	
Ambient temperature	T _A	-65 150		
Storage temperature	T _{Stq}	-65 150		

 ${}^{1}T_{S}$ is measured on the collector lead at the soldering point to the pcb





Thermal Resistance

Parameter	Symbol	Value	Unit
Junction - soldering point ¹⁾	R _{thJS}	250	K/W

Electrical Characteristics at T_A = 25 °C, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.]
DC Characteristics			•	•	•
Collector-emitter breakdown voltage	V _{(BR)CEO}	4.5	5.8	-	V
<i>I</i> _C = 1 mA, <i>I</i> _B = 0					
Collector-emitter cutoff current	I _{CES}				nA
V _{CE} = 15 V, V _{BE} = 0		-	-	1000	
$V_{\rm CE}$ = 2 V, $V_{\rm BE}$ = 0		-	1	30	
$V_{CE} = 5 \text{ V}, V_{BE} = 0 \text{ , } T_{A} = 85^{\circ}\text{C}$		-	2	40	
Verified by random sampling					
Collector-base cutoff current	I _{CBO}				
$V_{\rm CB}$ = 2 V, $I_{\rm E}$ = 0		-	1	30	
$V_{\rm CB}$ = 5 V, $I_{\rm E}$ = 0		-	-	30	
Emitter-base cutoff current	I _{EBO}	-	1	500	1
$V_{\rm EB}$ = 0,5 V, $I_{\rm C}$ = 0					
DC current gain	h _{FE}	90	120	160	-
$V_{\rm CE}$ = 3 V, $I_{\rm C}$ = 20 mA , pulse measured					

¹For the definition of R_{thJS} please refer to Application Note AN077 (Thermal Resistance Calculation)



Parameter	Symbol	Values			Unit
		min.	typ.	max.	
AC Characteristics (verified by random sampling)					
Transition frequency	f _T	16	22	-	GHz
$I_{\rm C}$ = 30 mA, $V_{\rm CE}$ = 3 V, f = 1 GHz					
Collector-base capacitance	C _{cb}	-	0.32	0.45	pF
$V_{\rm CB}$ = 3 V, f = 1 MHz, $V_{\rm BE}$ = 0 ,					
emitter grounded					
Collector emitter capacitance	C _{ce}	-	0.28	-	
$V_{CE} = 3 \text{ V}, f = 1 \text{ MHz}, V_{BE} = 0$,					
base grounded					
Emitter-base capacitance	C _{eb}	-	0.55	-	
$V_{\rm EB}$ = 0.5 V, f = 1 MHz, $V_{\rm CB}$ = 0 ,					
collector grounded					
Minimum noise figure	NF _{min}				dB
V_{CE} = 2V, I_{C} = 3 mA , Z_{S} = Z_{Sopt} , f = 100 MHz		-	0.7	-	
V_{CE} = 3V, I_{C} = 5 mA , Z_{S} = Z_{Sopt} , f = 1.8 GHz		-	1.1	-	
V_{CE} = 3V, I_C = 5 mA , Z_S = Z_{Sopt} , f = 3 GHz		-	1.2	-	

Electrical Characteristics at T_A = 25 °C, unless otherwise specified



Parameter	Symbol	Values		Unit			
		min.	typ.	max.			
AC Characteristics (verified by random sampling)							
Maximum power Gain ¹⁾	G _{max}				dB		
$I_{\rm C}$ = 3 mA, $V_{\rm CE}$ = 1.5 V, $Z_{\rm S}$ = $Z_{\rm Sopt,} Z_{\rm L}$ = $Z_{\rm Lopt}$,							
<i>f</i> = 100 MHz		-	26.5	-			
$I_{\rm C}$ = 20 mA, $V_{\rm CE}$ = 3 V, $Z_{\rm S}$ = $Z_{\rm Sopt}$, $Z_{\rm L}$ = $Z_{\rm Lopt}$,							
<i>f</i> = 1,8 GHz		-	17.5	-			
<i>f</i> = 3 GHz		-	12.5	-			
Transducer gain	S _{21e} ²				dB		
$I_{\rm C}$ = 3 mA, $V_{\rm CE}$ = 1.5 V, $Z_{\rm S}$ = $Z_{\rm L}$ = 50 Ω ,							
<i>f</i> = 100 MHz		-	20	-			
$I_{\rm C}$ = 20 mA, $V_{\rm CE}$ = 3 V, $Z_{\rm S}$ = $Z_{\rm L}$ = 50 Ω ,							
<i>f</i> = 1.8 GHz		-	15	-			
<i>f</i> = 3 GHz		-	10.5	-			
Third order intercept point at output ²⁾	IP3				dBm		
V _{CE} = 3 V, <i>I</i> _C = 20 mA, <i>f</i> = 100 MHz		-	23.5	-			
V _{CE} = 3 V, I _C = 20 mA, <i>f</i> = 1.8 GHz		-	27.5	-			
1dB compression point at output	P _{-1dB}						
$V_{\rm CE}$ = 3V, $I_{\rm C}$ = 20mA , $Z_{\rm S}$ = $Z_{\rm L}$ = 50 Ω , f = 100 MHz		-	9.5	-			
$V_{\rm CE}$ = 3V, $I_{\rm C}$ = 20mA, $Z_{\rm S}$ = $Z_{\rm L}$ = 50 Ω , f = 1.8 GHz		-	11.5	-			
$V_{\rm CE}$ = 3V, $I_{\rm C}$ = 35mA, $Z_{\rm S}$ = $Z_{\rm L}$ = 50 Ω , f = 1.8 GHz		-	13	-			

Electrical Characteristics at T_A	= 25 °C	unlage	othenwise	specified
Electrical characteristics at IA	- ZO C,	uniess	otherwise	specified

 ${}^{1}G_{\mathsf{ma}} = |S_{21} / S_{12}| \ (\mathsf{k}\text{-}(\mathsf{k}^{2}\text{-}1)^{1/2}), \ G_{\mathsf{ms}} = \left| S_{21} / S_{12} \right|$

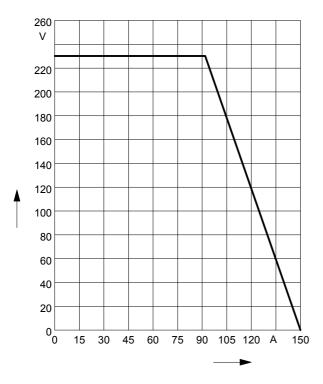
²IP3 value depends on termination of all intermodulation frequency components.

Termination used for this measurement is 50Ω from 0.1 MHz to 6 GHz

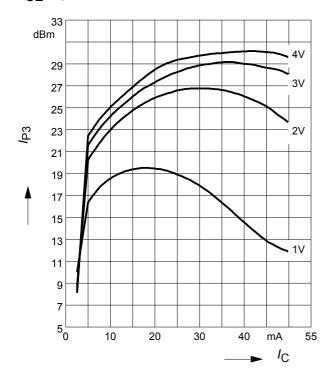


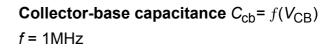
BFP460

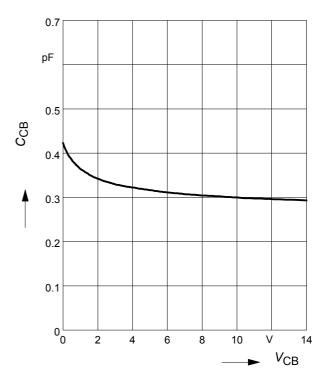
Total power dissipation $P_{tot} = f(T_S)$



Third order Intercept Point *IP3* = $f(I_C)$ (Output, $Z_S = Z_L = 50\Omega$) V_{CE} = parameter, *f* = 1800 MHz

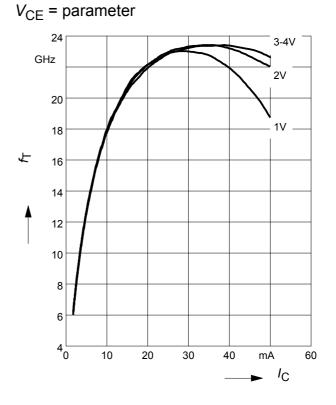






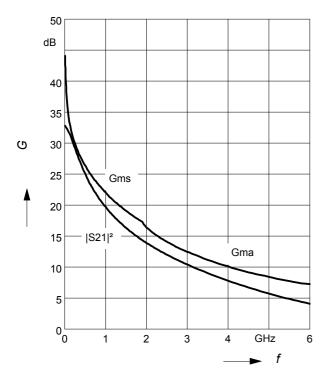
Transition frequency $f_{T} = f(I_{C})$

f = 1 GHz

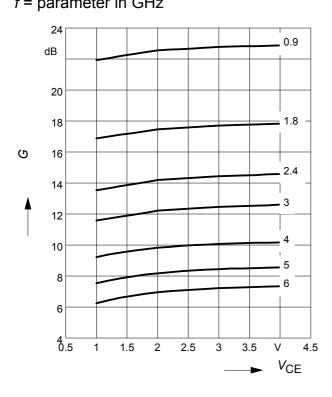




Power gain G_{ma} , G_{ms} , $|S_{21}|^2 = f(f)$ $V_{CE} = 3 \text{ V}$, $I_C = 20 \text{ mA}$



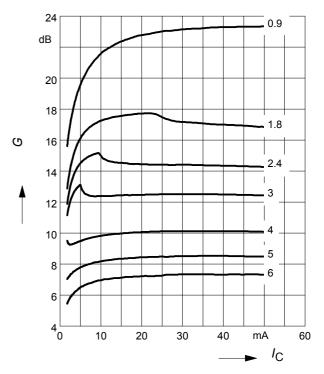
Power gain
$$G_{ma}$$
, $G_{ms} = f(V_{CE})$
 $I_{C} = 20 \text{ mA}$



Power gain G_{ma} , $G_{ms} = f(I_C)$

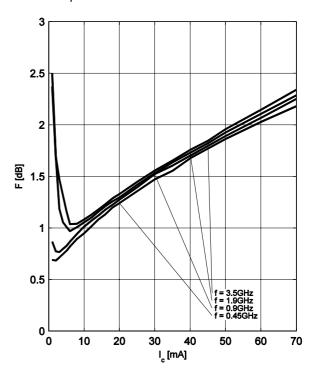
 $V_{CE} = 3V$

f = parameter in GHz



Noise figure $F = f(I_C)$ $V_{CE} = 2 \text{ V}, \text{ f} = \text{parameter}$

 $Z_{\rm S} = Z_{\rm Sopt}$

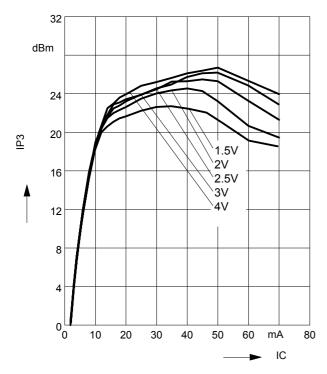




Third order Intercept Point $IP_3 = f(I_C)$

(Output, $Z_S = Z_L = 50\Omega$)

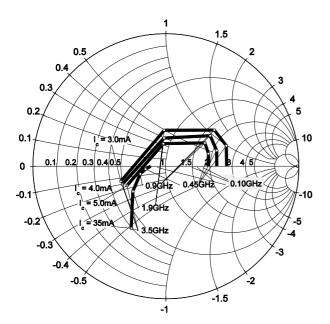
 V_{CE} = parameter, f = 100MHz



Source impedance for min.

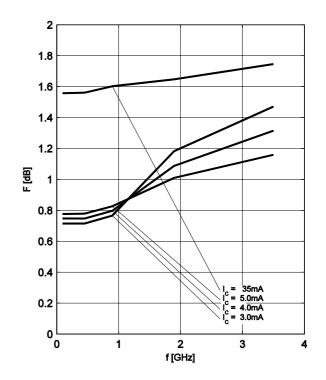
noise figure vs. frequency

 V_{CE} = 2V, I_{C} = parameter



Noise figure *F* = *f*(*f*)

 V_{CE} = 2V, Z_{S} = Z_{Sopt} , I_{C} = parameter



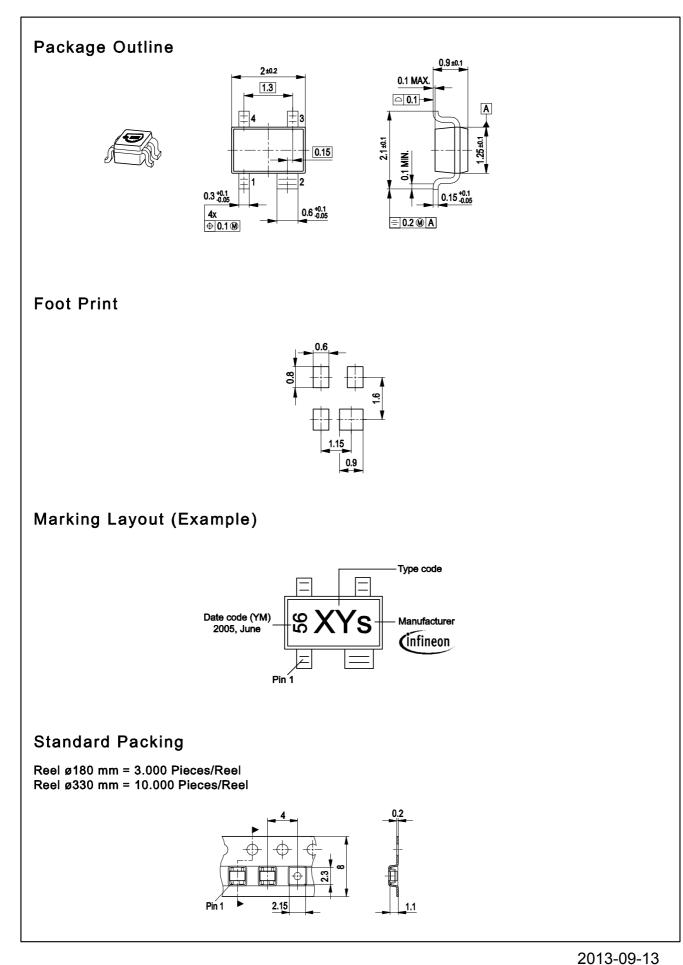


SPICE GP Model

For the SPICE Gummel Poon (GP) model as well as for the S-parameters (including noise parameters) please refer to our internet website www.infineon.com/rf.models.

Please consult our website and download the latest versions before actually starting your design. You find the BFP460 SPICE GP model in the internet in MWO- and ADS-format, which you can import into these circuit simulation tools very quickly and conveniently. The model already contains the package parasitics and is ready to use for DC and high frequency simulations. The terminals of the model circuit correspond to the pin configuration of the device. The model parameters have been extracted and verified up to 6 GHz using typical devices. The BFP460 SPICE GP model reflects the typical DC- and RF-performance within the limitations which are given by the SPICE GP model itself. Besides the DC characteristics all S-parameters in magnitude and phase, as well as noise figure (including optimum source impedance, equivalent noise resistance and flicker noise) and intermodulation have been extracted.









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